

CITATION PTO-1449		Applicant CAI, Lynn Filing Date 2/13/2002	Group 2623	RECEIVED DEC 06 2002 Technology Center 2100
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)				
EXAMINER'S INITIALS	CITATION			
<i>ck</i>	Lin. B.J., et al., "Single-Level Electric Testsites for Phase-Shifting Masks", SPIE, Vol. 1673, pp. 221-228, March 9-11, 1992.			

EXAMINER:

[Signature]

Date Considered:

11/13/04

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP § 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



INFORMATION DISCLOSURE CITATION PTO-1449		Atty. Docket No. NMTC-0765	Serial No. 10/074,751			
		Applicant CAI, Lynn	RECEIVED DEC 06 2002			
		Filing Date 2/13/2002	Group 2623	Technology Center 2100		
U.S. PATENT DOCUMENTS						
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE
CK	2002/0164064 A1	11/7/2002	Karklin, et al.	382	145	3/20/2001
W	2002/0164065 A1	11/7/2002	Cai, et al.	382	149	3/20/2001

EXAMINER:

Date Considered:

11/18/04

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP § 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE
CK	6,130,750	10/10/2000	Ausschnitt, et al.	356	401	8/28/1997
CK	6,346,426 B1	2/12/2002	Toprac, et al.	438	8	11/17/2000

EXAMINER:

Date Considered:

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